SEP 18 2006 W

DOCKET NO: 241677US-2

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF

•

KENJI YOSHIDA, ET AL.

: EXAMINER: STEVENSON, A.

SERIAL NO: 10/642,222

FILED: AUGUST 18, 2003

: GROUP ART UNIT: 2812

FOR: METHOD OF ACCELERATING TEST OF SEMICONDUCTOR DEVICE

<u>AMENDMENT</u>

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated May 17, 2006, please amend the aboveidentified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 5 of this paper.